

# 1 Channel High Side Switch ICs

# 1.1A Current Limit High Side Switch ICs

### **BD6519FJ**

### **General Description**

BD6519FJ is single channel high side switch IC with over-current protection for Universal Serial Bus (USB) power supply line. These are low ON-Resistance N-Channel power MOSFETs with low supply current. These ICs have built-in over-current protection circuit, thermal shutdown circuit, under voltage lockout and soft-start circuit.

#### **Features**

- Built-in Low ON-Resistance Nch MOSFET (Typ = 100mΩ)
- Control Input Logic: Active-Low
- Soft-Start Circuit
- Over-Current Protection
- Thermal Shutdown
- Under Voltage Lockout Function
- Open Drain Error Flag Output
- Reverse-Current Protection when Switch OFF

#### **Applications**

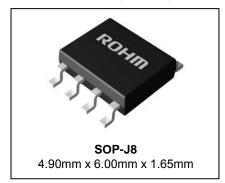
USB Hub in Consumer Appliances, PC, PC Peripheral Equipment

#### **Key Specifications**

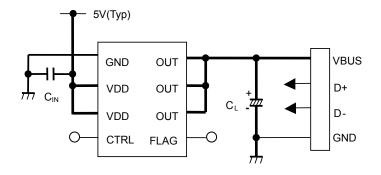
Input Voltage Range: 3.0V to 5.5V
 Continuous Current Load: 0.5A
 ON Resistance (V<sub>DD</sub>=5V) 100mΩ(Typ)
 Over-Current Threshold: 0.7A (Min), 1.6A (Max)
 Standby Current: 0.01μA (Typ)
 Operating Temperature Range: -40°C to +85°C

### **Package**

W(Typ) D(Typ) H (Max)



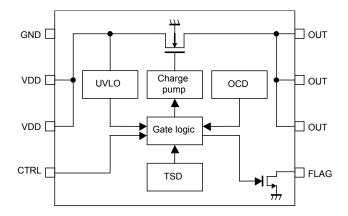
# **Typical Application Circuit**



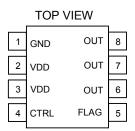
### Lineup

Over-Current Threshold		Control Input	Dookogo		Ondershie Deut Neumhen		
Min	Тур	Max	Logic	Package		Orderable Part Number	
0.7A	1.1A	1.6A	Low	SOP-J8	Reel of 2500	BD6519FJ-E2	

# **Block Diagram**



# **Pin Configuration**



Pin Description

n Description			
Pin No.	Symbol	1/0	Pin Function
1	GND	I	Ground pin
2, 3	VDD	I	Power supply input. Input terminal to power switch and power supply terminal of the internal circuit. When in use, connect each pin outside.
4	CTRL	I	Enable input.  Power switch on at low level.  High level input > 2.5V, low level input < 0.7V.
5	FLAG	0	Error flag output.  Low at over-current and thermal shutdown.  Open drain output.
6, 7, 8	OUT	0	Power switch output. When in use, connect each pin outside.

**Absolute Maximum Ratings** 

Parameter	Symbol	Limit	Unit
Supply Voltage	$V_{DD}$	-0.3 to +6.0	V
CTRL Voltage	$V_{CTRL}$	-0.3 to +6.0	V
FLAG Voltage	$V_{FLAG}$	-0.3 to +6.0	V
FLAG Current	I <sub>FLAG</sub>	10	mA
OUT Voltage	$V_{OUT}$	-0.3 to +6.0	V
Storage Temperature	Tstg	-55 to +150	°C
Power Dissipation	Pd	0.67 <sup>(Note 1)</sup>	W

(Note 1) Mounted on 70mm x 70mm x 1.6mm glass-epoxy PCB. Derating : 5.4mW/°C above Ta=25°C.

Caution: Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit between pins and the internal circuitry. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.

**Recommended Operating Conditions** 

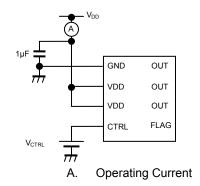
Parameter	Symbol		Unit		
Parameter		Min	Тур	Max	UIIIL
Operating Voltage	$V_{DD}$	3.0	-	5.5	V
Operating Temperature	Topr	-40	-	+85	°C
Continuous Output Current	I <sub>LO</sub>	0	-	500	mA

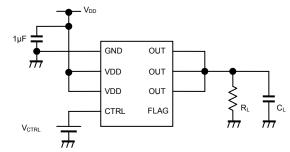
#### **Electrical Characteristics**

(Unless otherwise specified, V<sub>DD</sub> = 5.0V, Ta = 25°C)

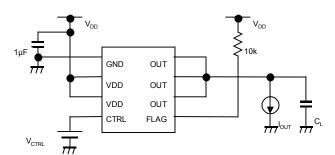
Parameter		Limit			Linit	Conditions
Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Operating Current		-	90	140	μA	V <sub>CTRL</sub> = 0V, OUT = OPEN
Standby Current	I <sub>DD</sub>	-	0.01	2	μA	V <sub>CTRL</sub> = 5V, OUT = OPEN
CTRL Input Voltage	V	2.5	-	-	V	High Input
CTRL Input voltage	$V_{CTRL}$	-	-	0.7	V	Low Input
CTRL Input Current	I <sub>CTRL</sub>	-1.0	+0.01	+1.0	μA	$V_{CTRL} = 0V$ or $V_{CTRL} = 5V$
FLAG Output Resistance	$R_{FLAG}$	-	180	450	Ω	I <sub>FLAG</sub> = 1mA
FLAG Output Leak Current	$I_{L\_FLAG}$	-	0.01	1	μA	V <sub>FLAG</sub> = 5V
FLAG Output Delay	$t_{D\_FLAG}$	-	2.5	8	ms	
ON-Resistance	Ron	-	100	140	mΩ	$V_{DD} = 5V, I_{OUT} = 500mA$
ON-Resistance		-	140	180	mΩ	$V_{DD} = 3.3V, I_{OUT} = 500mA$
Short Circuit Output Current	$I_{SC}$	0.6	-	1.6	Α	$V_{DD} = 5V$ , $V_{OUT} = 0V$
Output Leak Current	$I_{LEAK}$	-	-	10	μA	V <sub>CTRL</sub> = 5V
Output Rise Time	t <sub>ON1</sub>	-	1	4	ms	
Output Turn ON Delay Time	$t_{\text{ON2}}$	-	1.3	6	ms	$R_L = 10\Omega$ , $C_L = OPEN$
Output Fall Time	$t_{OFF1}$	-	1	20	μs	RL = 1012, CL = OF EN
Output Turn OFF Delay Time	t <sub>OFF2</sub>	-	3	20	μs	
Thermal Shutdown Threshold	T <sub>TS</sub>	-	135	-	°C	Tj Increase
Over-Current Threshold	I <sub>TH</sub>	0.7	1.1	1.6	Α	
UVLO Threshold	$V_{TUVH}$	2.3	2.5	2.7	V	V <sub>DD</sub> Increasing
OVEO THESHOLD	$V_{TUVL}$	2.1	2.3	2.5	V	V <sub>DD</sub> Decreasing

### **Measurement Circuit**

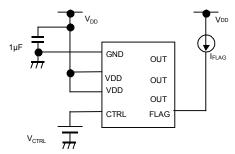




B. CTRL Input Voltage, Output Rise / Fall Time



C. ON-Resistance, Over-Current Detection



D. FLAG Output Low Voltage

Figure 1. Measurement Circuit

# **Timing Diagram**

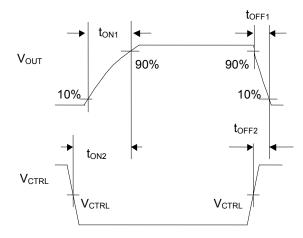


Figure 2. Timing Diagram

# **Typical Performance Curves**

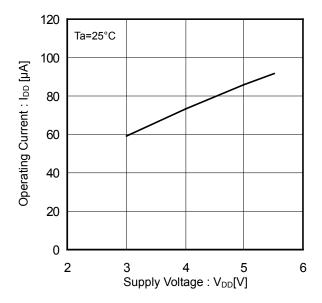


Figure 3. Operating Current vs Supply Voltage (CTRL Enable)

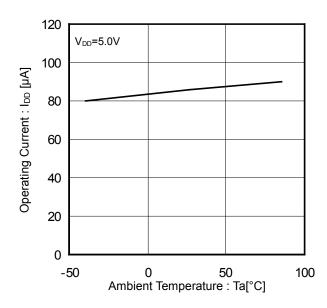


Figure 4. Operating Current vs Ambient Temperature (CTRL Enable)

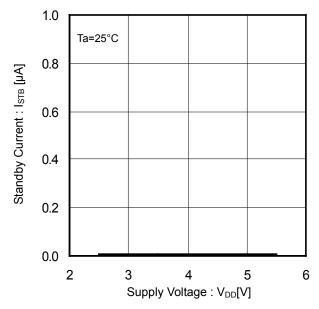


Figure 5. Standby Current vs Supply Voltage (CTRL Disable)

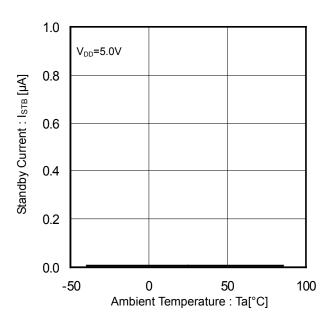


Figure 6. Standby Current vs Ambient Temperature (CTRL Disable)

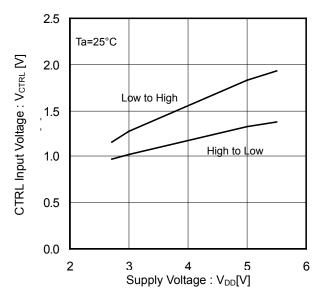


Figure 7. CTRL Input Voltage vs Supply Voltage

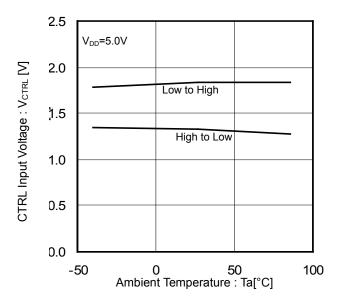


Figure 8. CTRL Input Voltage vs Ambient Temperature

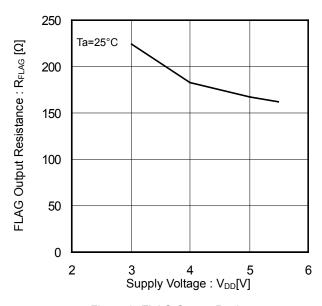


Figure 9. FLAG Output Resistance vs Supply Voltage

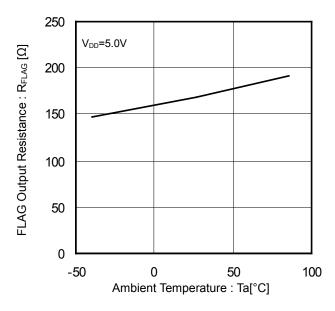


Figure 10. FLAG Output Resistance vs Ambient Temperature

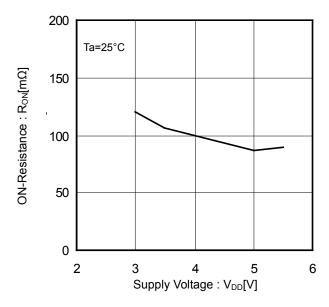


Figure 11. ON-Resistance vs Supply Voltage

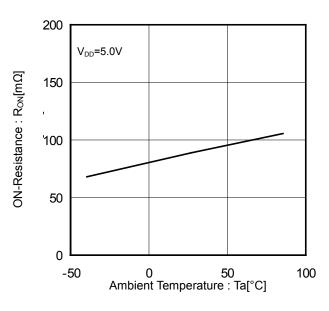


Figure 12. ON-Resistance vs Ambient Temperature

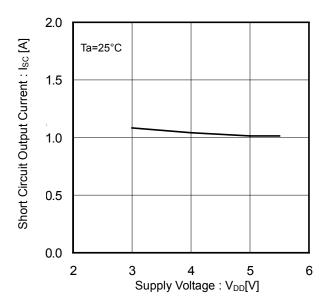


Figure 13. Short Circuit Output Current vs Supply Voltage

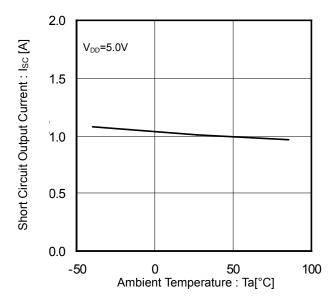


Figure 14. Short Circuit Output Current vs Ambient Temperature

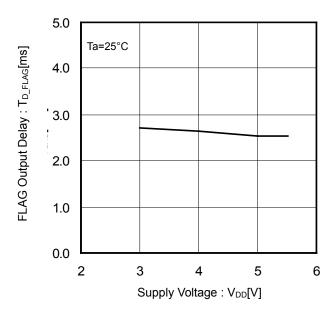


Figure 15. FLAG Output Delay vs Supply Voltage

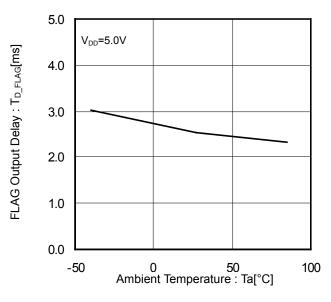


Figure 16. FLAG Output Delay vs Ambient Temperature

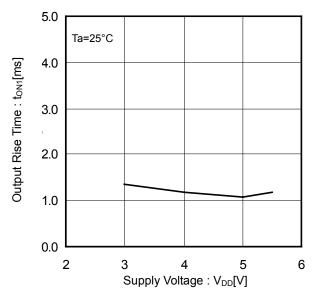


Figure 17. Output Rise Time vs Supply Voltage

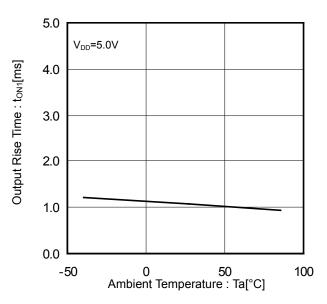


Figure 18. Output Rise Time vs Ambient Temperature

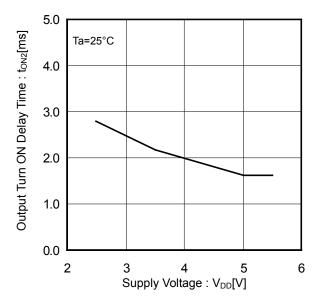


Figure 19. Output Turn ON Delay Time vs Supply Voltage

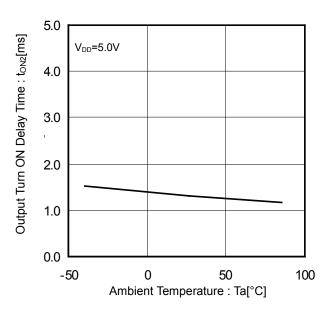


Figure 20. Output Turn ON Delay Time vs Ambient Temperature

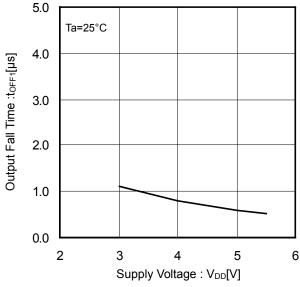


Figure 21. Output Fall Time vs Supply Voltage

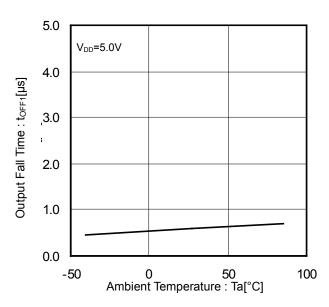


Figure 22. Output Fall Time vs Ambient Temperature

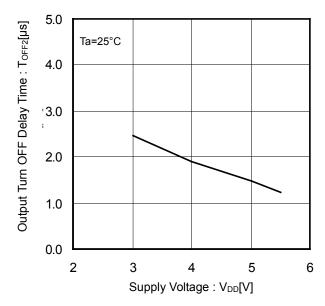


Figure 23. Output Turn OFF Delay Time vs Supply Voltage

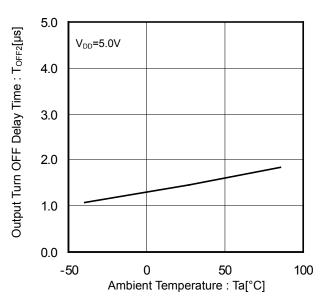


Figure 24. Output Turn OFF Delay Time vs Ambient Temperature

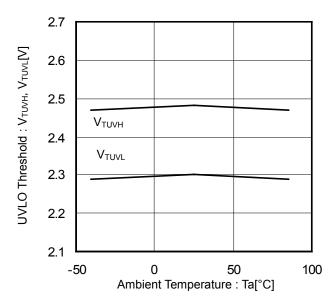


Figure 25. UVLO Threshold Voltage vs Ambient Temperature

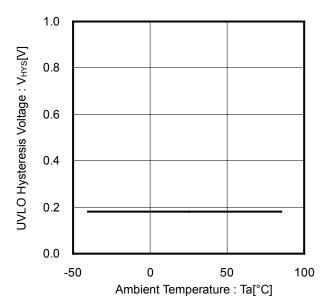


Figure 26. UVLO Hysteresis Voltage vs Ambient Temperature

# **Typical Wave Forms**

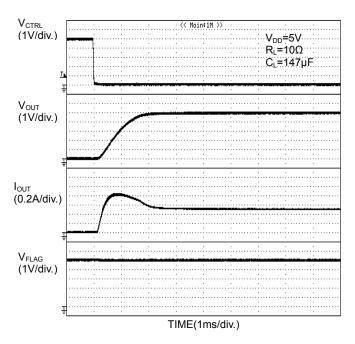


Figure 27. Output Rise Characteristic

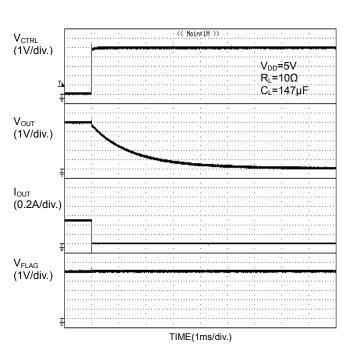


Figure 28. Output Fall Characteristic

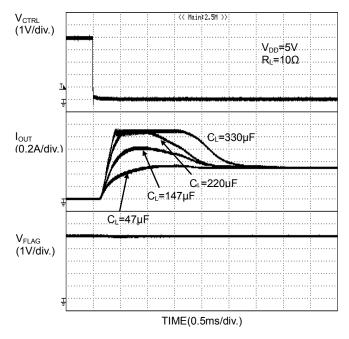


Figure 29. Inrush Current Characteristic

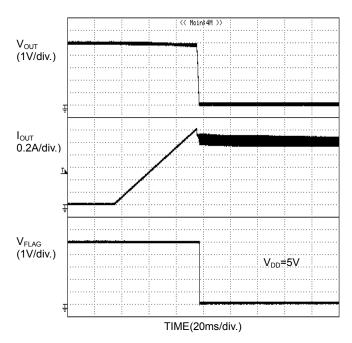


Figure 30. Over-Current Response Ramped Load

# Typical Wave Forms - continued

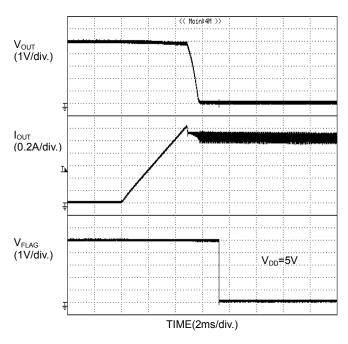


Figure 31. Over-Current Response Ramped Load

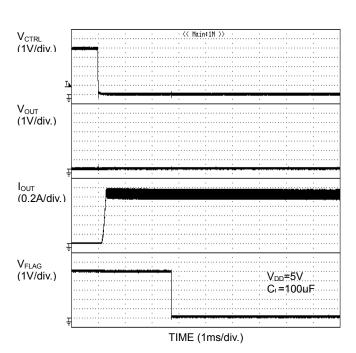


Figure 32. Over-Current Response Enable to Short Circuit

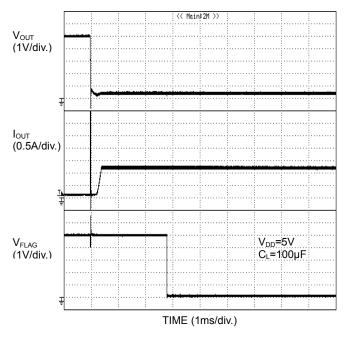


Figure 33. Over-Current Response Output Short Circuit at Enable

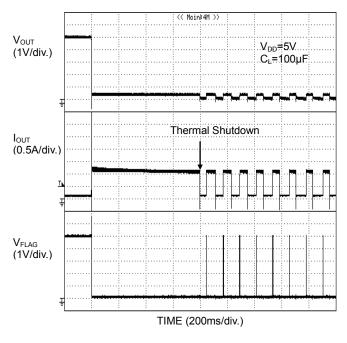
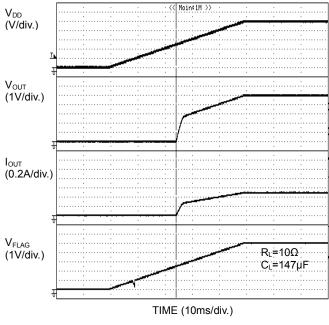


Figure 34. Over-Current Response Output Short Circuit at Enable

# Typical Wave Forms - continued



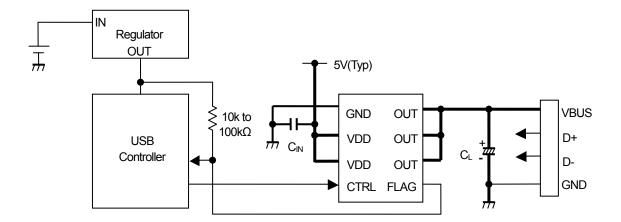
 $V_{\text{OUT}}$  (1V/div.)  $I_{\text{OUT}}$  (0.2A/div.)  $V_{\text{FLAG}}$   $R_{\text{L}}$  = 10 $\Omega$   $C_{\text{L}}$  = 14 $T\mu\text{F}$ 

V<sub>DD</sub> (V/div.)

Figure 35. UVLO  $V_{DD}$  Increasing

Figure 36. UVLO V<sub>DD</sub> Decreasing

### **Typical Application Circuit**



### **Application Information**

When excessive current flows due to output short circuit or so, ringing occurs by inductance of power source line and IC. This may cause bad effects on IC operations. In order to avoid this case, a bypass capacitor should be connected across by VDD terminal and GND terminal of IC. 1µF or higher is recommended.

Pull-up FLAG output by resistance  $10k\Omega$  to  $100k\Omega$ .

Set-up values for C<sub>L</sub> which satisfies the application.

This application circuit does not guarantee its operation. When using the circuit with changes to the external circuit constants, it is better to have an adequate margin for the external components such as static and transient characteristics as well as dispersion of the IC.

#### **Functional Description**

### 1. Switch Operation

VDD terminal and OUT terminal are connected to the drain and the source of switch MOSFET respectively. The VDD terminal is also used as power source input to internal control circuit.

When the switch is turned ON by CTRL input, both the VDD and OUT terminals are connected by a  $100m\Omega$  bidirectional switch. In on status, the switch is bidirectional. Therefore, current flows from OUT terminal to VDD terminal since the potential of OUT terminal is higher than that of VDD terminal.

On the other hand, when the switch is turned OFF, it is possible to prevent current from flowing reversely from OUT to VDD since a parasitic diode between the drain and the source of switch MOSFET is not activated.

#### 2. Thermal Shutdown Circuit (TSD)

If over-current would continue, the temperature of the IC would increase drastically. If the junction temperature is beyond 135°C (Typ) during the condition of over-current detection, thermal shutdown circuit operates and turns the power switch OFF, causing the IC to output an error flag (FLAG). Then, when the junction temperature drops lower than 125°C (Typ), power switch is turned ON and error flag (FLAG) is cancelled. This operation repeats unless the cause of the increase in chip's temperature is removed or the output of power switch is turned OFF.

The thermal shutdown circuit operates when the switch is ON (CTRL signal is active)

#### 3. Over-Current Detection (OCD)

The over-current detection circuit limits current ( $I_{SC}$ ) and outputs error flag (FLAG) when current flowing in each switch MOSFET exceeds a specified value. The over-current detection circuit works when the switch is ON (CTRL signal is active). There are three types of response against over-current:

- (1) When the switch is turned on while the output is in short circuit status, the switch goes into current limit status immediately
- (2) When the output short circuits or high-current load is connected while the switch is ON, very large current flows until the over-current limit circuit reacts. When it exceeds detection value, current limitation is carried out.
- (3) When the output current increases gradually, current limit circuit would not operate unless the output current exceeds the over-current detection value. But when the output current increases gradually and it exceeds the detection value, current limitation is carried out.

#### 4. Under Voltage Lockout (UVLO)

UVLO circuit prevents the switch from turning on until VDD exceeds 2.3V(Typ). If the VDD drops below 2.3V(Typ) while the switch is ON, then UVLO shuts off the power switch. UVLO has hysteresis of a 200mV(Typ). Under voltage lockout circuit works when the switch is on (CTRL signal is active).

#### 5. Error Flag (FLAG) Output

Error flag output is N-MOS open drain output. During detection of over-current and/or thermal shutdown, the output level is low. Over-current detection has delay filter of 2.5ms(Typ). This delay filter prevents current detection flags from being sent during instantaneous events such as inrush current at switch on or during hot plug. If error flag output is unused, Flag pin should be connected to open or ground line.

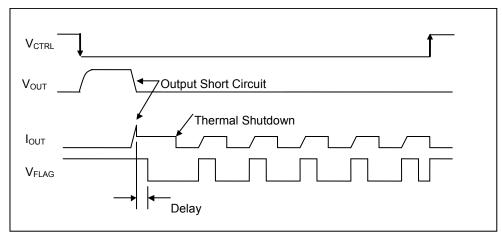
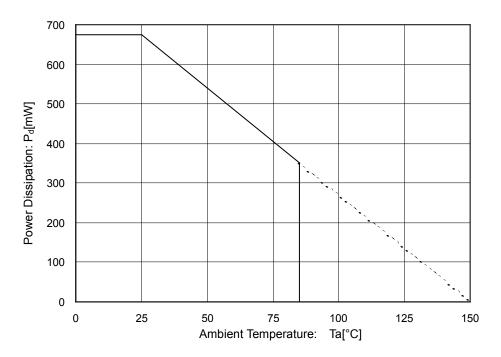


Figure 37. Over-Current Detection, Thermal Shutdown Timing Diagram

# **Power Dissipation**

(SOP-J8)



70mm x 70mm x 1.6mm Glass Epoxy Board

Figure 38. Power Dissipation Curve (Pd-Ta Curve)

I/O Equivalence Circuit

Equivalence Circuit							
Symbol Pin No		Equivalence Circuit					
CTRL	4						
FLAG	5						
OUT	6,7,8						

#### **Operational Notes**

#### 1. Reverse Connection of Power Supply

Connecting the power supply in reverse polarity can damage the IC. Take precautions against reverse polarity when connecting the power supply, such as mounting an external diode between the power supply and the IC's power supply pins.

#### 2. Power Supply Lines

Design the PCB layout pattern to provide low impedance supply lines. Separate the ground and supply lines of the digital and analog blocks to prevent noise in the ground and supply lines of the digital block from affecting the analog block. Furthermore, connect a capacitor to ground at all power supply pins. Consider the effect of temperature and aging on the capacitance value when using electrolytic capacitors.

#### 3. Ground Voltage

Ensure that no pins are at a voltage below that of the ground pin at any time, even during transient condition.

#### 4. Ground Wiring Pattern

When using both small-signal and large-current ground traces, the two ground traces should be routed separately but connected to a single ground at the reference point of the application board to avoid fluctuations in the small-signal ground caused by large currents. Also ensure that the ground traces of external components do not cause variations on the ground voltage. The ground lines must be as short and thick as possible to reduce line impedance.

#### 5. Thermal Consideration

Should by any chance the power dissipation rating be exceeded the rise in temperature of the chip may result in deterioration of the properties of the chip. The absolute maximum rating of the Pd stated in this specification is when the IC is mounted on a 70mm x 70mm x 1.6mm glass epoxy board. In case of exceeding this absolute maximum rating, increase the board size and copper area to prevent exceeding the Pd rating.

#### 6. Recommended Operating Conditions

These conditions represent a range within which the expected characteristics of the IC can be approximately obtained. The electrical characteristics are guaranteed under the conditions of each parameter.

#### 7. In rush Current

When power is first supplied to the IC, it is possible that the internal logic may be unstable and inrush current may flow instantaneously due to the internal powering sequence and delays, especially if the IC has more than one power supply. Therefore, give special consideration to power coupling capacitance, power wiring, width of ground wiring, and routing of connections.

#### 8. Operation Under Strong Electromagnetic Field

Operating the IC in the presence of a strong electromagnetic field may cause the IC to malfunction.

### 9. Testing on Application Boards

When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.

### 10. Inter-pin Short and Mounting Errors

Ensure that the direction and position are correct when mounting the IC on the PCB. Incorrect mounting may result in damaging the IC. Avoid nearby pins being shorted to each other especially to ground, power supply and output pin. Inter-pin shorts could be due to many reasons such as metal particles, water droplets (in very humid environment) and unintentional solder bridge deposited in between pins during assembly to name a few.

### **Operational Notes - continued**

#### 11. Unused Input Pins

Input pins of an IC are often connected to the gate of a MOS transistor. The gate has extremely high impedance and extremely low capacitance. If left unconnected, the electric field from the outside can easily charge it. The small charge acquired in this way is enough to produce a significant effect on the conduction through the transistor and cause unexpected operation of the IC. So unless otherwise specified, unused input pins should be connected to the power supply or ground line.

#### 12. Regarding the Input Pin of the IC

This monolithic IC contains P+ isolation and P substrate layers between adjacent elements in order to keep them isolated. P-N junctions are formed at the intersection of the P layers with the N layers of other elements, creating a parasitic diode or transistor. For example (refer to figure below):

When GND > Pin A and GND > Pin B, the P-N junction operates as a parasitic diode. When GND > Pin B, the P-N junction operates as a parasitic transistor.

Parasitic diodes inevitably occur in the structure of the IC. The operation of parasitic diodes can result in mutual interference among circuits, operational faults, or physical damage. Therefore, conditions that cause these diodes to operate, such as applying a voltage lower than the GND voltage to an input pin (and thus to the P substrate) should be avoided.

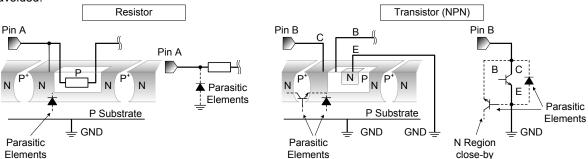


Figure 39. Example of monolithic IC structure

#### 13. Ceramic Capacitor

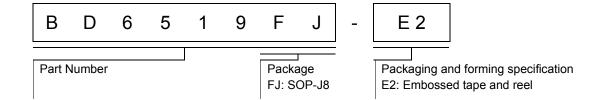
When using a ceramic capacitor, determine the dielectric constant considering the change of capacitance with temperature and the decrease in nominal capacitance due to DC bias and others.

### 14. Thermal Shutdown Circuit(TSD)

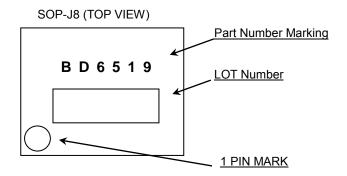
This IC has a built-in thermal shutdown circuit that prevents heat damage to the IC. Normal operation should always be within the IC's power dissipation rating. If however the rating is exceeded for a continued period, the junction temperature (Tj) will rise which will activate the TSD circuit that will turn OFF all output pins. When the Tj falls below the TSD threshold, the circuits are automatically restored to normal operation.

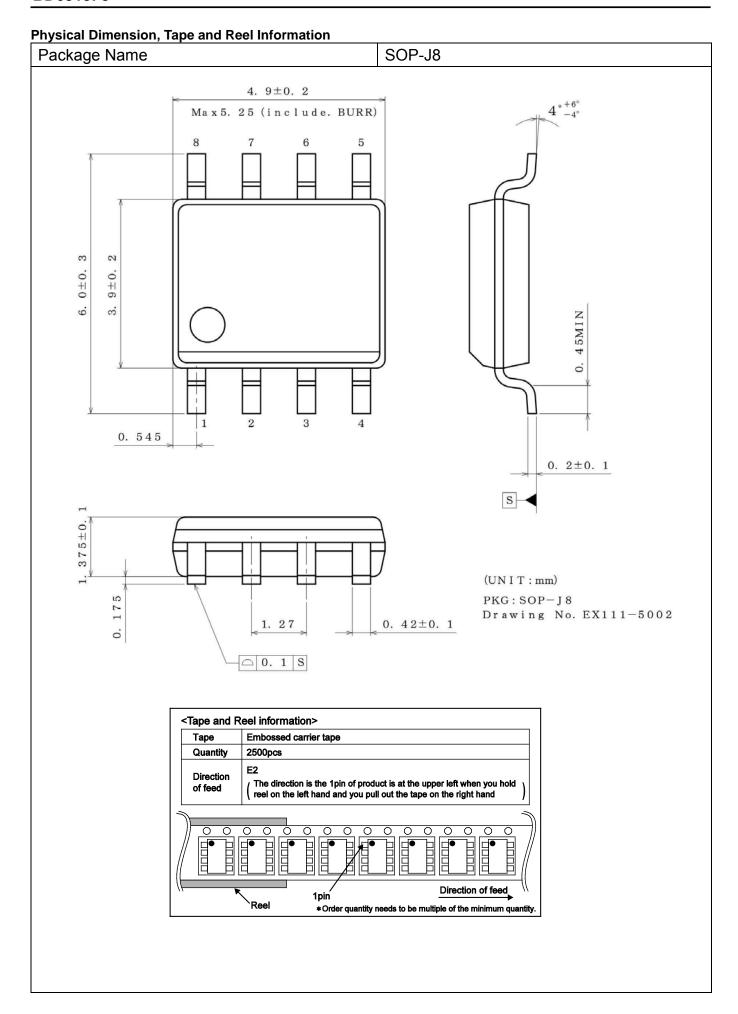
Note that the TSD circuit operates in a situation that exceeds the absolute maximum ratings and therefore, under no circumstances, should the TSD circuit be used in a set design or for any purpose other than protecting the IC from heat damage.

# **Ordering Information**



# **Marking Diagram**





# **Revision History**

Date	Revision	Changes	
11.Mar.2013	001	New Release	
21.Aug.2014	002	Applied the ROHM Standard Style and improved understandability.	

# **Notice**

### **Precaution on using ROHM Products**

Our Products are designed and manufactured for application in ordinary electronic equipments (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment (Note 1), transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASSⅢ	CLASSⅢ	CLASS II b	CLASSIII
CLASSIV	CLASSIII	CLASSⅢ	CLASSIII

- 2. ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
  - [a] Installation of protection circuits or other protective devices to improve system safety
  - [b] Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- 3. Our Products are designed and manufactured for use under standard conditions and not under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc, prior to use, must be necessary:
  - [a] Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
  - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - [f] Sealing or coating our Products with resin or other coating materials
  - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

#### Precaution for Mounting / Circuit board design

- 1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- 2. In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

# **Precautions Regarding Application Examples and External Circuits**

- If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
- You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

#### **Precaution for Electrostatic**

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of Ionizer, friction prevention and temperature / humidity control).

### **Precaution for Storage / Transportation**

- 1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl2, H2S, NH3, SO2, and NO2
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
- 2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
- 3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

### Precaution for Product Label

QR code printed on ROHM Products label is for ROHM's internal use only.

#### **Precaution for Disposition**

When disposing Products please dispose them properly using an authorized industry waste company.

#### **Precaution for Foreign Exchange and Foreign Trade act**

Since our Products might fall under controlled goods prescribed by the applicable foreign exchange and foreign trade act, please consult with ROHM representative in case of export.

#### **Precaution Regarding Intellectual Property Rights**

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